

# CEP6060L/CEB6060L



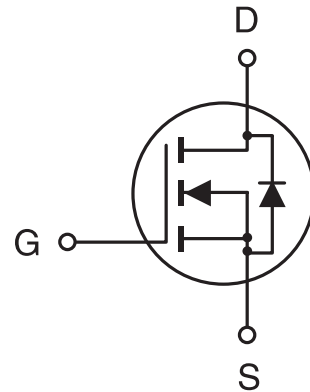
March 1998

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## N-Channel Enhancement Mode Field Effect Transistor

### FEATURES

- 60V , 48A ,  $R_{DS(ON)}=20m\Omega$  @  $V_{GS}=10V$ .  
 $R_{DS(ON)}=25m\Omega$  @  $V_{GS}= 5 V$ .
- Super high dense cell design for extremely low  $R_{DS(ON)}$ .
- High power and current handling capability.
- TO-220 & TO-263 package.



### ABSOLUTE MAXIMUM RATINGS ( $T_c=25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	60	V
Gate-Source Voltage	$V_{GS}$	$\pm 16$	V
Drain Current -Continuous -Pulsed	$I_D$	48	A
	$I_{DM}$	144	A
Drain-Source Diode Forward Current	$I_S$	60	A
Maximum Power Dissipation @ $T_c=25^{\circ}C$ Derate above $25^{\circ}C$	$P_D$	100	W
		0.67	W/ $^{\circ}C$
Operating and Storage Temperature Range	$T_J, T_{STG}$	-65 to 175	$^{\circ}C$

### THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	1.5	$^{\circ}C/W$
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	$^{\circ}C/W$

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## ELECTRICAL CHARACTERISTICS (Tc=25°C unless otherwise noted)

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Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	60			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =60V, V <sub>GS</sub> = 0V			25	μA
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>GS</sub> =±16V, V <sub>DS</sub> =0V			±100	nA
ON CHARACTERISTICS <sup>a</sup>						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> = 250μA	1	1.4	2	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 5V, I <sub>D</sub> = 24A		19	25	mΩ
		V <sub>GS</sub> = 10V, I <sub>D</sub> = 24A		15	20	mΩ
On-State Drain Current	I <sub>D(ON)</sub>	V <sub>GS</sub> = 5V, V <sub>DS</sub> = 10V	60			A
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> = 10V, I <sub>D</sub> = 24A		39		S
DYNAMIC CHARACTERISTICS <sup>b</sup>						
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> =25V, V <sub>GS</sub> = 0V f =1.0MHz		1565	2000	pF
Output Capacitance	C <sub>OSS</sub>			441	600	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			104	140	pF
SWITCHING CHARACTERISTICS <sup>b</sup>						
Turn-On Delay Time	t <sub>D(ON)</sub>	V <sub>DD</sub> = 30V, I <sub>D</sub> = 48A, V <sub>GS</sub> = 5V V <sub>GEN</sub> = 15V R <sub>GS</sub> =15Ω		20	30	ns
Rise Time	t <sub>r</sub>			400	500	ns
Turn-Off Delay Time	t <sub>D(OFF)</sub>			75	100	ns
Fall Time	t <sub>f</sub>			260	300	ns
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =48V, I <sub>D</sub> = 48A, V <sub>GS</sub> =5V		58	60	nC
Gate-Source Charge	Q <sub>gs</sub>			8		nC
Gate-Drain Charge	Q <sub>gd</sub>			13		nC

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## ELECTRICAL CHARACTERISTICS ( $T_c=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>DRAIN-SOURCE DIODE CHARACTERISTICS <sup>a</sup></b>						
Diode Forward Voltage	$V_{SD}$	$V_{GS} = 0V, I_S = 24A$		0.8	1.3	V

Notes

a. Pulse Test: Pulse Width  $\leq 300 \mu s$ , Duty Cycle  $\leq 2\%$ .

b. Guaranteed by design, not subject to production testing.

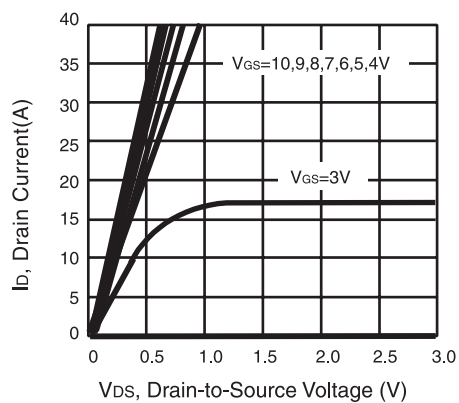


Figure 1. Output Characteristics

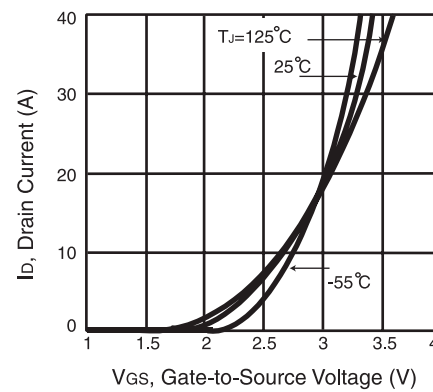


Figure 2. Transfer Characteristics

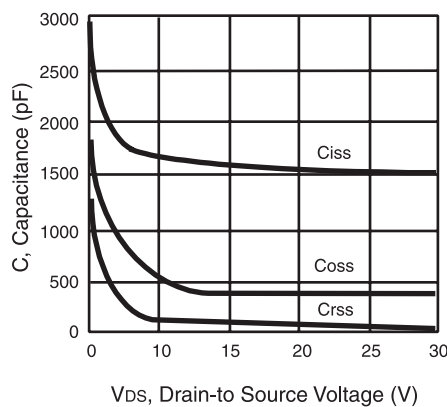


Figure 3. Capacitance

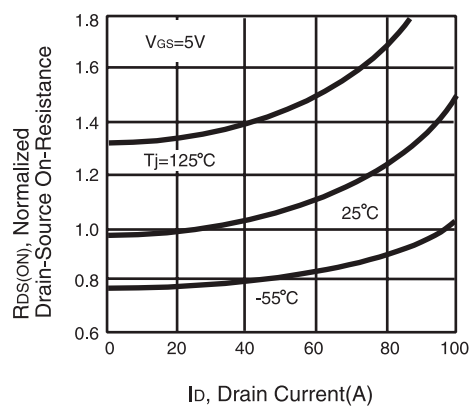
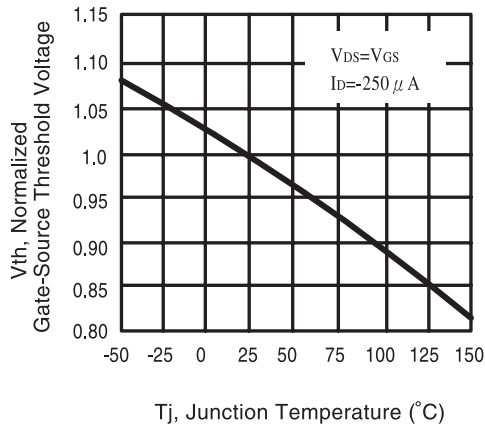


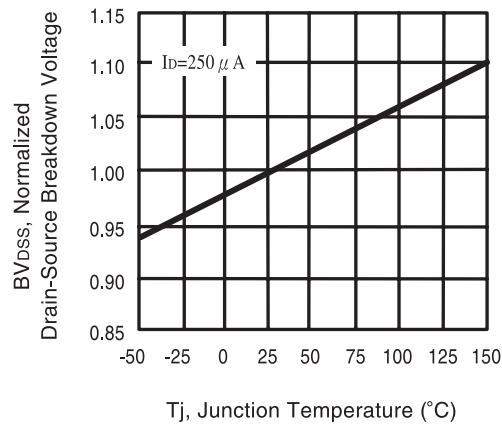
Figure 4. On-Resistance Variation with Drain Current and Temperature

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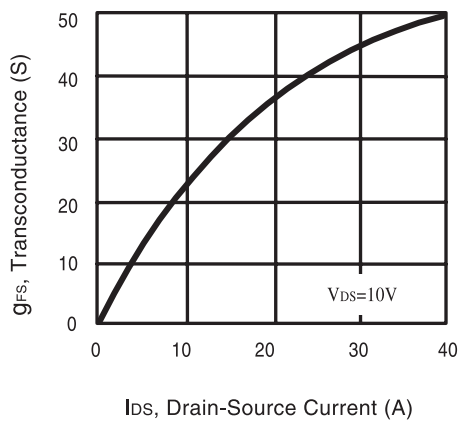
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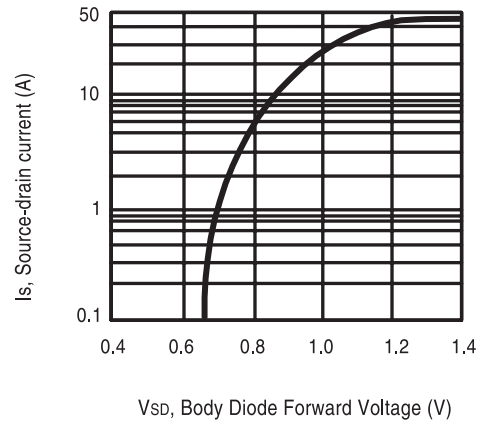
**Figure 5. Gate Threshold Variation with Temperature**



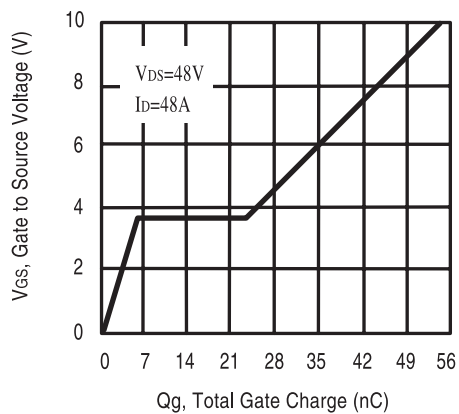
**Figure 6. Breakdown Voltage Variation with Temperature**



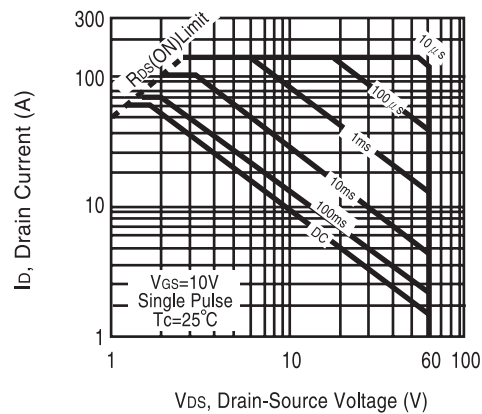
**Figure 7. Transconductance Variation with Drain Current**



**Figure 8. Body Diode Forward Voltage Variation with Source Current**



**Figure 9. Gate Charge**



**Figure 10. Maximum Safe Operating Area**

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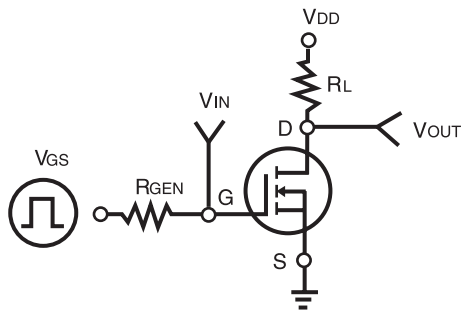


Figure 11. Switching Test Circuit

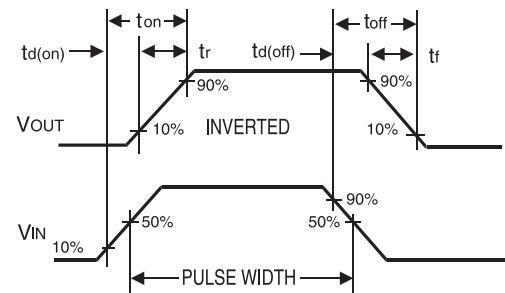


Figure 12. Switching Waveforms

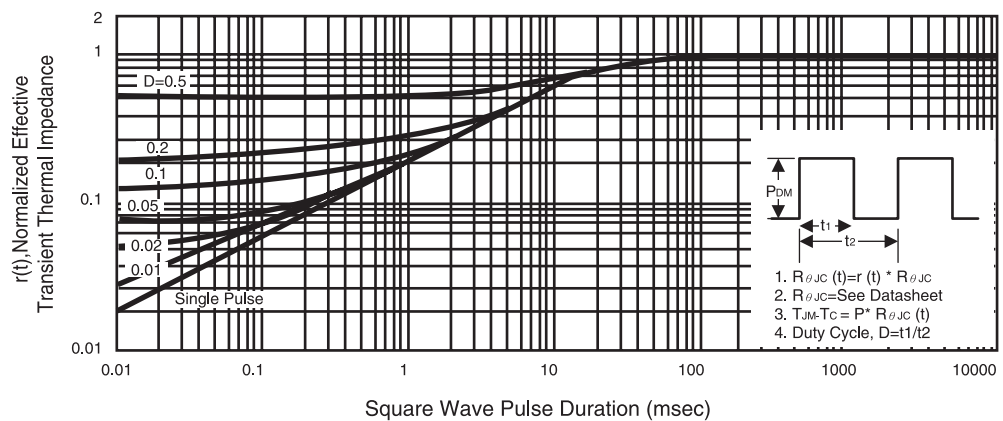


Figure 13. Normalized Thermal Transient Impedance Curve